Notice of References Cited Application/Control No. 10/829,323 Applicant(s)/Patent Under Reexamination STILER Examiner TAN Q. NGUYEN Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,189,619 A	02-1993	Adachi et al.	701/96
*	В	US-6,571,176 B1	05-2003	Shinmura et al.	701/301
*	С	US-7,126,460 B2	10-2006	Yamada, Keiichi	340/435
	D	US-			
	E	US-			
	F	ÚS-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-		·	
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N				<u> </u>	
	0				·	
	Р					
	Q					
	R					,
	S					:
	Т					-

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	×	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.